

### 3.3V 'SpreadTrak' Zero Delay Buffer

#### Features

- Zero input - output propagation delay, adjustable by capacitive load on FBK input.
- Multiple configurations - Refer "ASM5P23S04A Configurations Table".
- Input frequency range: 15 MHz to 133 MHz
- Multiple low-skew outputs.
- Output-output skew less than 200 pS.
- Device-device skew less than 500 pS.
- Two banks of two outputs each.
- Less than 200 pS cycle-to-cycle jitter
  - (-1, -1H, -2, -2H).
- Available in space saving, 8-pin 150-mil SOIC package.
- 3.3V operation.
- Advanced 0.35µ CMOS technology.
- Industrial temperature available.
- 'SpreadTrak'.

FBK pin, and can be obtained from one of the outputs. The input-to-output propagation delay is guaranteed to be less than 250 pS, and the output-to-output skew is guaranteed to be less than 200 pS.

The ASM5P23S04A has two banks of two outputs each. Multiple ASM5P23S04A devices can accept the same input clock and distribute it. In this case the skew between the outputs of the two devices is guaranteed to be less than 500 pS.

The ASM5P23S04A is available in two different configurations (Refer "ASM5P23S04A Configurations Table"). The ASM5P23S04A-1 is the base part, where the output frequencies equal the reference if there is no counter in the feedback path. The ASM5P23S04A-1H is the high-drive version of the -1 and the rise and fall times on this device are much faster.

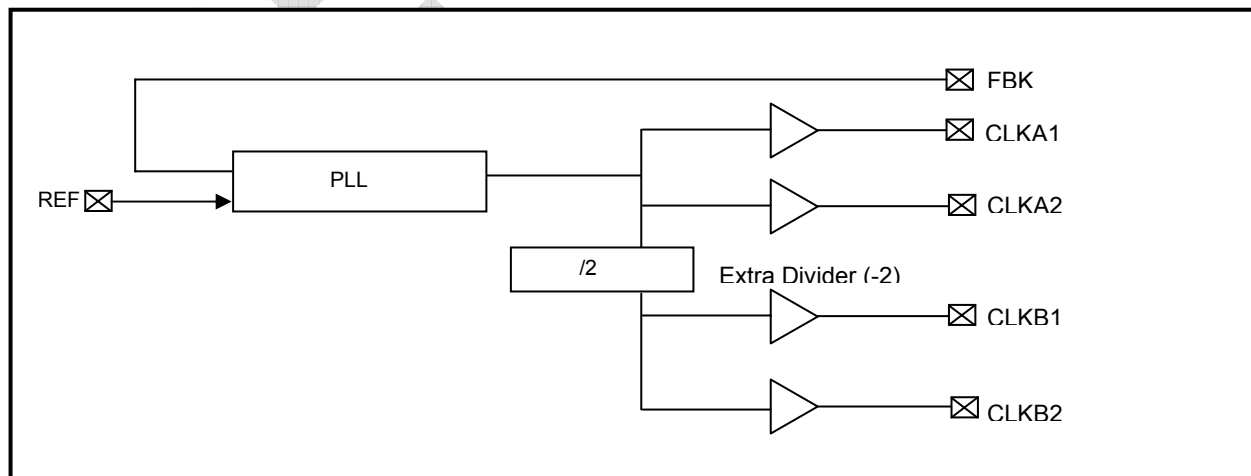
#### Functional Description

ASM5P23S04A is a versatile, 3.3V zero-delay buffer designed to distribute high-speed clocks in PC, workstation, datacom, telecom and other high-performance applications. It is available in a 8-pin package. The part has an on-chip PLL, which locks to an input clock, presented on the REF pin. The PLL feedback is required to be driven to

The ASM5P23S04A-2 allows the user to obtain Ref and 1/2X frequencies on each output bank. The exact configuration and output frequencies depend on which output drives the feedback pin.

The ASM5P23S04A-2H is a high-drive version with REF/2 on both banks.

#### Block Diagram



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ASM5P23S04A Configurations

Device	Feedback From	Bank A Frequency	Bank B Frequency
ASM5P23S04A-1	Bank A or Bank B	Reference	Reference
ASM5P23S04A-1H	Bank A or Bank B	Reference	Reference
ASM5P23S04A-2	Bank A or Bank B	Reference	Reference /2
ASM5P23S04A-2H	Bank A or Bank B	Reference	Reference /2

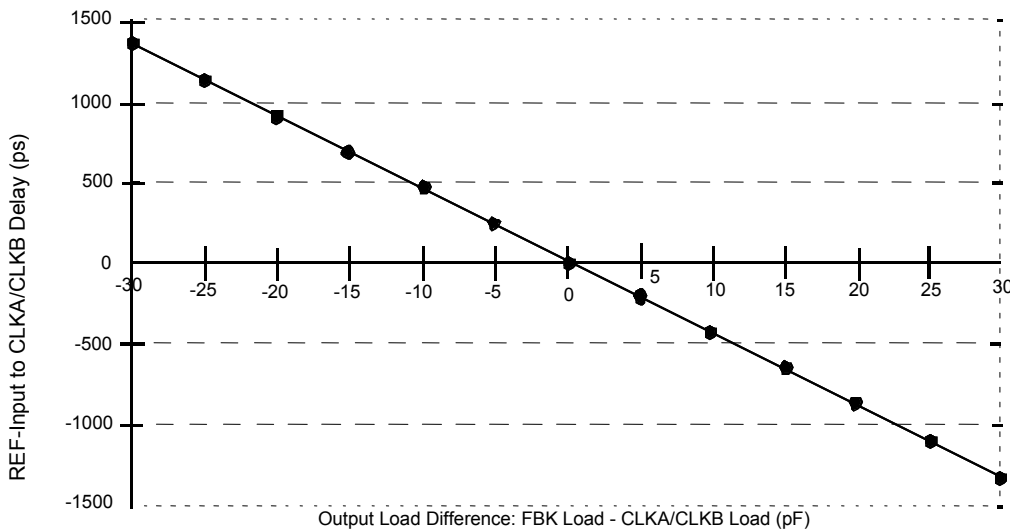
**‘SpreadTrak’**

Many systems being designed now utilize a technology called Spread Spectrum Frequency Timing Generation. ASM5P23S04A is designed so as not to filter off the Spread Spectrum feature of the Reference Input, assuming it exists. When a zero delay buffer is not designed to pass the Spread Spectrum feature through, the result is a

significant amount of tracking skew which may cause problems in the systems requiring synchronization.

**Zero Delay and Skew Control**

For applications requiring zero input-output delay, all outputs must be equally loaded.



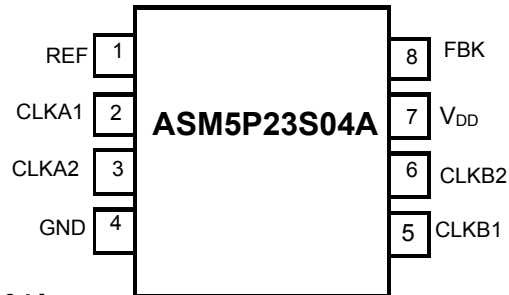
REF Input to CLKA/CLKB Delay Vs Difference in Loading between FBK pin and CLKA/CLKB pins

To close the feedback loop of the ASM5P23S04A, the FBK pin can be driven from any of the four available output pins. The output driving the FBK pin will be driving a total load of 7pF plus any additional load that it drives. The relative loading of this output (with respect to the remaining outputs) can adjust the input output delay. This is shown in the above graph.

For applications requiring zero input-output delay, all outputs including the one providing feedback should be equally loaded. If input-output delay adjustments are required, use the above graph to calculate loading differences between the feedback output and remaining outputs. For zero output-output skew, be sure to load outputs equally.

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Pin Configuration



Pin Description for ASM5P23S04A

Pin #	Pin Name	Description
1	REF <sup>1</sup>	Input reference frequency, 5V tolerant input
2	CLKA1 <sup>2</sup>	Buffered clock output, bank A
3	CLKA2 <sup>2</sup>	Buffered clock output, bank A
4	GND	Ground
5	CLKB1 <sup>2</sup>	Buffered clock output, bank B
6	CLKB2 <sup>2</sup>	Buffered clock output, bank B
7	V <sub>DD</sub>	3.3V supply
8	FBK	PLL feedback input

Notes:

1. Weak pull-down.
2. Weak pull-down on all outputs.

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**Absolute Maximum Ratings**

Parameter	Min	Max	Unit
Supply Voltage to Ground Potential	-0.5	+7.0	V
DC Input Voltage (Except REF)	-0.5	$V_{DD} + 0.5$	V
DC Input Voltage (REF)	-0.5	7	V
Storage Temperature	-65	+150	°C
Max. Soldering Temperature (10 sec)		260	°C
Junction Temperature		150	°C
Static Discharge Voltage (per MIL-STD-883, Method 3015)		>2000	V

Note: These are stress ratings only and functional usage is not implied. Exposure to absolute maximum ratings for prolonged periods can affect device reliability.

**Operating Conditions for ASM5P23S04A Commercial Temperature Devices**

Parameter	Description	Min	Max	Unit
$V_{DD}$	Supply Voltage	3.0	3.6	V
$T_A$	Operating Temperature (Ambient Temperature)	0	70	°C
$C_L$	Load Capacitance, below 100 MHz		30	pF
$C_L$	Load Capacitance, from 100 MHz to 133 MHz		15	pF
$C_{IN}$	Input Capacitance <sup>3</sup>		7	pF

Note:

3. Applies to both Ref Clock and FBK.

Electrical Characteristics for ASM5P23S04A Commercial Temperature Devices

Parameter	Description	Test Conditions	Min	Max	Unit
V <sub>IL</sub>	Input LOW Voltage			0.8	V
V <sub>IH</sub>	Input HIGH Voltage		2.0		V
I <sub>IL</sub>	Input LOW Current	V <sub>IN</sub> = 0V		50.0	μA
I <sub>IH</sub>	Input HIGH Current	V <sub>IN</sub> = V <sub>DD</sub>		100.0	μA
V <sub>OL</sub>	Output LOW Voltage <sup>4</sup>	I <sub>OL</sub> = 8mA (-1, -2) I <sub>OH</sub> = 12mA (-1H, -2H)		0.4	V
V <sub>OH</sub>	Output HIGH Voltage <sup>4</sup>	I <sub>OL</sub> = -8mA (-1, -2) I <sub>OH</sub> = -12mA (-1H, -2H)	2.4		V
I <sub>DD</sub>	Supply Current	Unloaded outputs 100MHz REF, Select inputs at V <sub>DD</sub> or GND		TBD	mA
				TBD	
		Unloaded outputs, 66MHz REF (-1, -2)		TBD	
		Unloaded outputs, 33MHz REF (-1, -2)		TBD	

Note:

4. Parameter is guaranteed by design and characterization. Not 100% tested in production.

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Switching Characteristics for ASM5P23S04A Commercial Temperature Devices

Parameter	Description	Test Conditions	Min	Typ	Max	Unit
1/t <sub>1</sub>	Output Frequency	30 pF load, All devices	15		100	MHz
1/t <sub>1</sub>	Output Frequency	20 pF load, -1H, -2H devices	15		133	MHz
1/t <sub>1</sub>	Output Frequency	15 pF load, -1, -2 devices	15		133	MHz
	Duty Cycle <sup>5</sup> = (t <sub>2</sub> / t <sub>1</sub> ) * 100 (-1, -2, -1H, -2H)	Measured at 1.4V, F <sub>OUT</sub> = 66.66 MHz 30 pF load	40.0	50.0	60.0	%
	Duty Cycle <sup>5</sup> = (t <sub>2</sub> / t <sub>1</sub> ) * 100 (-1, -2, -1H, -2H)	Measured at 1.4V, F <sub>OUT</sub> = <50 MHz 15 pF load	45.0	50.0	55.0	%
t <sub>3</sub>	Output Rise Time <sup>5</sup> (-1, -2)	Measured between 0.8V and 2.0V 30 pF load			2.20	nS
t <sub>3</sub>	Output Rise Time <sup>5</sup> (-1, -2)	Measured between 0.8V and 2.0V 15 pF load			1.50	nS
t <sub>3</sub>	Output Rise Time <sup>5</sup> (-1H, -2H)	Measured between 0.8V and 2.0V 30 pF load			1.50	nS
t <sub>4</sub>	Output Fall Time <sup>5</sup> (-1, -2)	Measured between 2.0V and 0.8V 30 pF load			2.20	nS
t <sub>4</sub>	Output Fall Time <sup>5</sup> (-1, -2)	Measured between 2.0V and 0.8V 15 pF load			1.50	nS
t <sub>4</sub>	Output Fall Time <sup>5</sup> (-1H, -2H)	Measured between 2.0V and 0.8V 30 pF load			1.25	nS
t <sub>5</sub>	Output-to-output skew on same bank (-1, -2) <sup>5</sup>	All outputs equally loaded			200	pS
	Output-to-output skew (-1H, -2H)	All outputs equally loaded			200	
	Output bank A -to- output bank B skew (-1, -2H)	All outputs equally loaded			200	
	Output bank A to output bank B skew (-2)	All outputs equally loaded			400	
t <sub>6</sub>	Delay, REF Rising Edge to FBK Rising Edge <sup>5</sup>	Measured at V <sub>DD</sub> /2		0	±250	pS
t <sub>7</sub>	Device-to-Device Skew <sup>5</sup>	Measured at V <sub>DD</sub> /2 on the FBK pins of the device		0	500	pS
t <sub>8</sub>	Output Slew Rate <sup>5</sup>	Measured between 0.8V and 2.0V using Test Circuit #2	1			V/nS
t <sub>J</sub>	Cycle-to-cycle jitter <sup>5</sup> (-1, -1H, -2H)	Measured at 66.67 MHz, loaded outputs, 15 pF load			175	pS
		Measured at 66.67 MHz, loaded outputs, 30 pF load			200	
		Measured at 133 MHz, loaded outputs, 15 pF load			100	
t <sub>J</sub>	Cycle-to-cycle jitter <sup>5</sup> (-2)	Measured at 66.67 MHz, loaded outputs, 30 pF load			400	pS
		Measured at 66.67 MHz, loaded outputs, 15 pF load			375	
t <sub>LOCK</sub>	PLL Lock Time <sup>5</sup>	Stable power supply, valid clock presented on REF and FBK pins			1.0	mS

Note:

5. Parameter is guaranteed by design and characterization. Not 100% tested in production.

Operating Conditions for ASM5I23S04A Industrial Temperature Devices

Parameter	Description	Min	Max	Unit
V <sub>DD</sub>	Supply Voltage	3.0	3.6	V
T <sub>A</sub>	Operating Temperature (Ambient Temperature)	-40	85	°C
C <sub>L</sub>	Load Capacitance, below 100 MHz		30	pF
C <sub>L</sub>	Load Capacitance, from 100 MHz to 133 MHz		15	pF
C <sub>IN</sub>	Input Capacitance <sup>6</sup>		7	pF

Note:

6. Applies to both Ref Clock and FBK.

Electrical Characteristics for ASM5I23S04A Industrial Temperature Devices

Parameter	Description	Test Conditions	Min	Max	Unit
V <sub>IL</sub>	Input LOW Voltage			0.8	V
V <sub>IH</sub>	Input HIGH Voltage		2.0		V
I <sub>IL</sub>	Input LOW Current	V <sub>IN</sub> = 0V		50.0	μA
I <sub>IH</sub>	Input HIGH Current	V <sub>IN</sub> = V <sub>DD</sub>		100.0	μA
V <sub>OL</sub>	Output LOW Voltage <sup>7</sup>	I <sub>OL</sub> = 8mA (-1, -2) I <sub>OH</sub> = 12mA (-1H, -2H)		0.4	V
V <sub>OH</sub>	Output HIGH Voltage <sup>7</sup>	I <sub>OL</sub> = -8mA (-1, -2) I <sub>OH</sub> = -12mA (-1H, -2H)	2.4		V
I <sub>DD</sub>	Supply Current	Unloaded outputs 100MHz REF, Select inputs at V <sub>DD</sub> or GND		TBD	mA
				TBD	
		Unloaded outputs, 66MHz REF (-1, -2)		TBD	
		Unloaded outputs, 33MHz REF (-1, -2)		TBD	

Note:

7. Parameter is guaranteed by design and characterization. Not 100% tested in production.

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Switching Characteristics for ASM5I23S04A Industrial Temperature Devices

Parameter	Description	Test Conditions	Min	Typ	Max	Unit
t <sub>1</sub>	Output Frequency	30 pF load, All devices	15		100	MHz
t <sub>1</sub>	Output Frequency	20 pF load, -1H, -2H devices	15		133	MHz
t <sub>1</sub>	Output Frequency	15 pF load, -1 and -2 devices	15		133	MHz
	Duty Cycle <sup>8</sup> = (t <sub>2</sub> / t <sub>1</sub> ) * 100 (-1, -2, -1H, -2H)	Measured at 1.4V, F <sub>OUT</sub> = <66.66 MHz 30 pF load	40.0	50.0	60.0	%
	Duty Cycle <sup>8</sup> = (t <sub>2</sub> / t <sub>1</sub> ) * 100 (-1, -2, -1H, -2H)	Measured at 1.4V, F <sub>OUT</sub> = <50 MHz 15 pF load	45.0	50.0	55.0	%
t <sub>3</sub>	Output Rise Time <sup>8</sup> (-1, -2)	Measured between 0.8V and 2.0V 30 pF load			2.50	nS
t <sub>3</sub>	Output Rise Time <sup>8</sup> (-1, -2)	Measured between 0.8V and 2.0V 15 pF load			1.50	nS
t <sub>3</sub>	Output Rise Time <sup>8</sup> (-1H, -2H)	Measured between 0.8V and 2.0V 30 pF load			1.50	nS
t <sub>4</sub>	Output Fall Time <sup>8</sup> (-1, -2)	Measured between 2.0V and 0.8V 30 pF load			2.50	nS
t <sub>4</sub>	Output Fall Time <sup>8</sup> (-1, -2)	Measured between 2.0V and 0.8V 15 pF load			1.50	nS
t <sub>4</sub>	Output Fall Time <sup>8</sup> (-1H, -2H)	Measured between 2.0V and 0.8V 30 pF load			1.25	nS
t <sub>5</sub>	Output-to-output skew on same bank (-1, -2) <sup>8</sup>	All outputs equally loaded			200	pS
	Output-to-output skew (-1H, -2H)	All outputs equally loaded			200	
	Output bank A -to- output bank B skew (-1, -2H)	All outputs equally loaded			200	
	Output bank A -to- output bank B skew (-2)	All outputs equally loaded			400	
t <sub>6</sub>	Delay <sub>8</sub> , REF Rising Edge to FBK Rising Edge	Measured at V <sub>DD</sub> / 2		0	±250	pS
t <sub>7</sub>	Device-to-Device Skew <sup>8</sup>	Measured at V <sub>DD</sub> /2 on the FBK pins of the device		0	500	pS
t <sub>8</sub>	Output Slew Rate <sup>8</sup>	Measured between 0.8V and 2.0V using Test Circuit #2	1			V/nS
t <sub>J</sub>	Cycle-to-cycle jitter <sup>8</sup> (-1, -1H, -2H)	Measured at 66.67 MHz, loaded outputs, 15 pF load			180	pS
		Measured at 66.67 MHz, loaded outputs, 30 pF load			200	
		Measured at 133 MHz, loaded outputs, 15 pF load			100	
t <sub>J</sub>	Cycle-to-cycle jitter <sup>8</sup> (-2)	Measured at 66.67 MHz, loaded outputs, 30 pF load			400	pS
		Measured at 66.67 MHz, loaded outputs, 15 pF load			380	
t <sub>LOCK</sub>	PLL Lock Time <sup>8</sup>	Stable power supply, valid clock presented on REF and FBK pins			1.0	mS

Note:

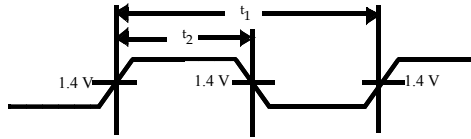
8. Parameter is guaranteed by design and characterization. Not 100% tested in production.



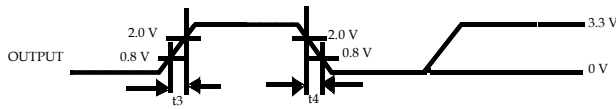
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Switching Waveforms

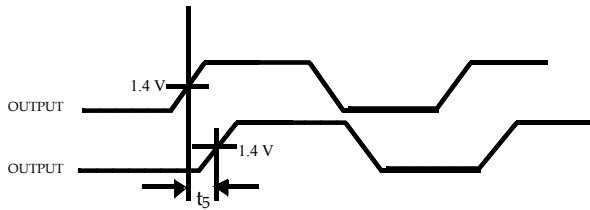
Duty Cycle Timing



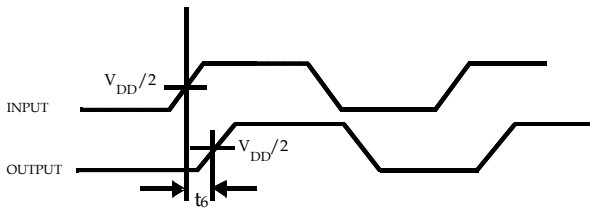
All Outputs Rise/Fall Time



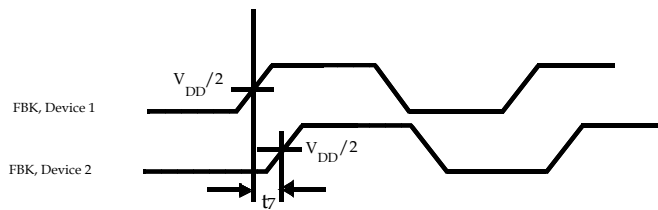
Output - Output Skew



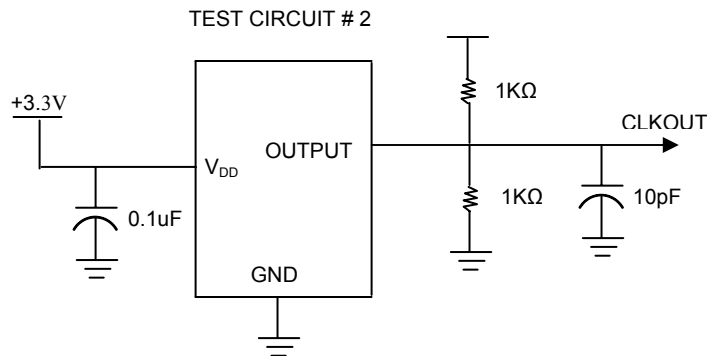
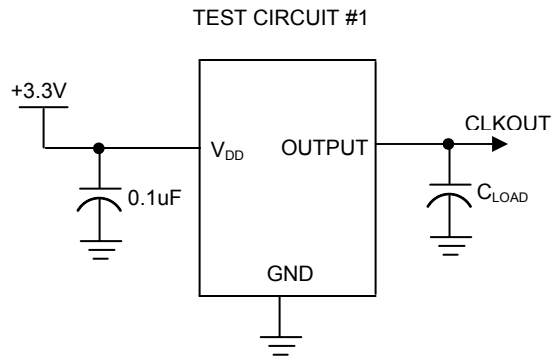
Input - Output Propagation Delay



Device - Device Skew



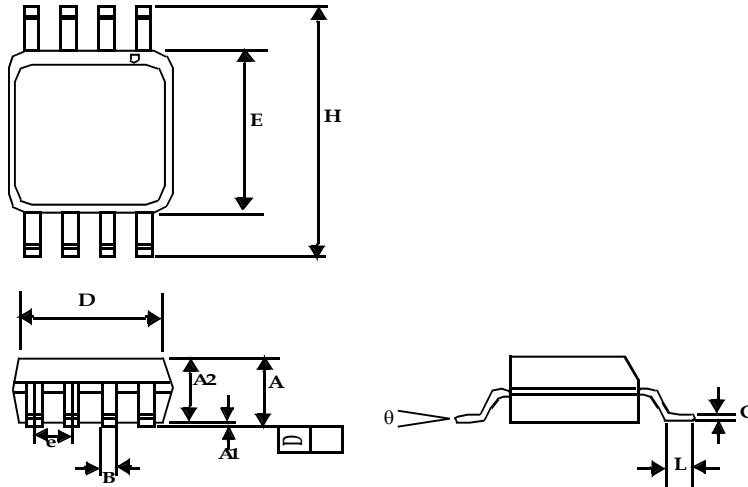
Test Circuits



For parameter  $t_b$  (output skew rate) on -1H devices

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Package Information: 8-lead (150 Mil) Molded SOIC



Symbol	Dimensions			
	Inches		Millimeters	
	Min	Max	Min	Max
A1	0.004	0.010	0.10	0.25
A	0.053	0.069	1.35	1.75
A2	0.049	0.059	1.25	1.50
B	0.012	0.020	0.31	0.51
C	0.007	0.010	0.18	0.25
D	0.193 BSC		4.90 BSC	
E	0.154 BSC		3.91 BSC	
e	0.050 BSC		1.27 BSC	
H	0.236 BSC		6.00 BSC	
L	0.016	0.050	0.41	1.27
θ	0°	8°	0°	8°

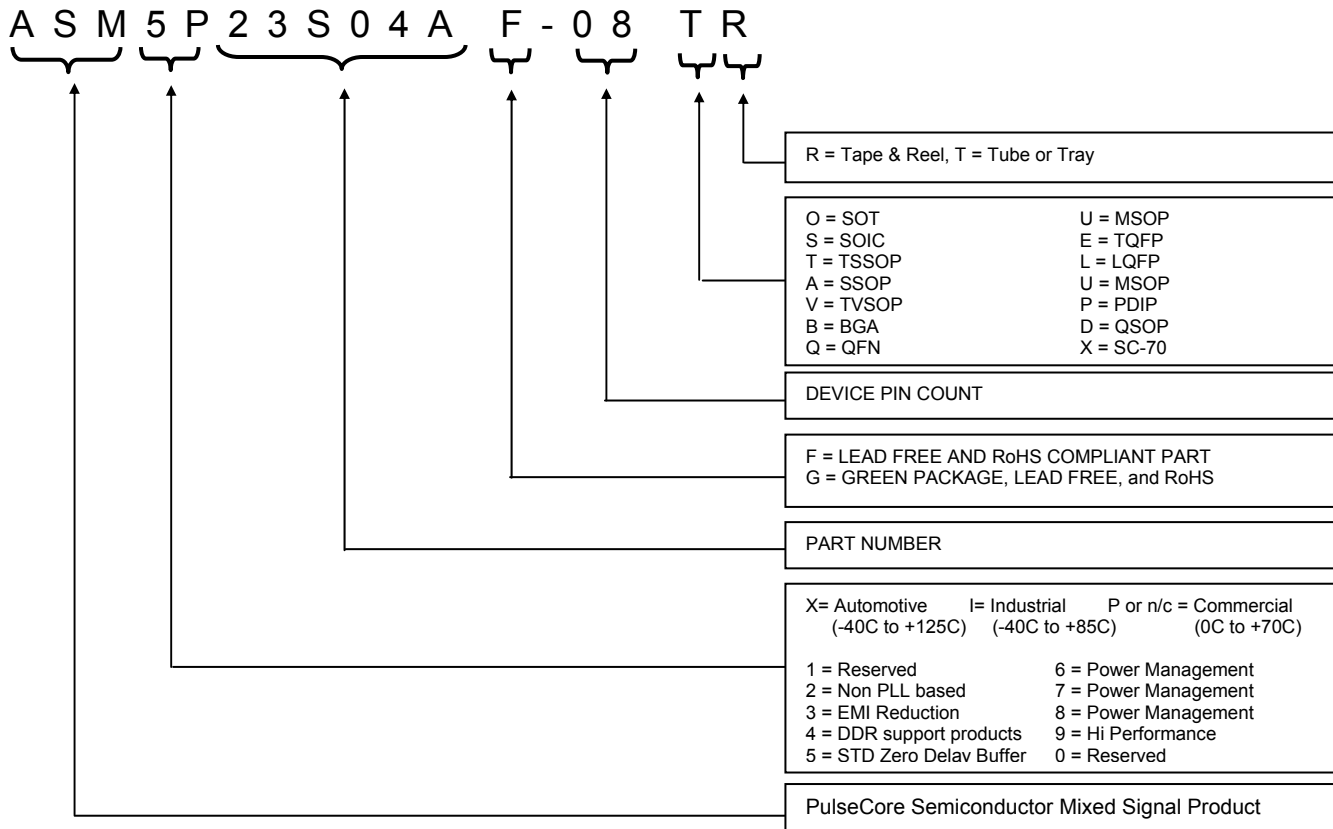
Ordering Codes

Ordering Code	Marking	Package Type	Temperature
ASM5P23S04AF-1-08-SR	5P23S04AF-1	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Commercial
ASM5P23S04AF-1-08-ST	5I23S04AF-1	8-pin 150-mil SOIC-TUBE, Pb free	Commercial
ASM5I23S04AF-1-08-SR	5P23S04AF-1	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Industrial
ASM5I23S04AF-1-08-ST	5I23S04AF-1	8-pin 150-mil SOIC-TUBE, Pb free	Industrial
ASM5P23S04AF-1H-08-SR	5P23S04AF-1H	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Commercial
ASM5P23S04AF-1H-08-ST	5I23S04AF-1H	8-pin 150-mil SOIC-TUBE, Pb free	Commercial
ASM5I23S04AF-1H-08-SR	5P23S04AF-1H	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Industrial
ASM5I23S04AF-1H-08-ST	5I23S04AF-1H	8-pin 150-mil SOIC-TUBE, Pb free	Industrial
ASM5P23S04AF-2-08-SR	5P23S04AF-2	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Commercial
ASM5P23S04AF-2-08-ST	5I23S04AF-2	8-pin 150-mil SOIC-TUBE, Pb free	Commercial
ASM5I23S04AF-2-08-SR	5P23S04AF-2	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Industrial
ASM5I23S04AF-2-08-ST	5I23S04AF-2	8-pin 150-mil SOIC-TUBE, Pb free	Industrial
ASM5P23S04AF-2H-08-SR	5P23S04AF-2H	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Commercial
ASM5P23S04AF-2H-08-ST	5I23S04AF-2H	8-pin 150-mil SOIC-TUBE, Pb free	Commercial
ASM5I23S04AF-2H-08-SR	5P23S04AF2H	8-pin 150-mil SOIC-TAPE & REEL, Pb free	Industrial
ASM5I23S04AF-2H-08-ST	5I23S04AFH	8-pin 150-mil SOIC-TUBE, Pb free	Industrial

Ordering Codes (Contd...)

Ordering Code	Marking	Package Type	Temperature
ASM5P23S04AG-1-08-SR	5P23S04AG-1	8-pin 150-mil SOIC-TAPE & REEL, Green	Commercial
ASM5P23S04AG-1-08-ST	5I23S04AG-1	8-pin 150-mil SOIC-TUBE, Green	Commercial
ASM5I23S04AG-1-08-SR	5P23S04AG-1	8-pin 150-mil SOIC-TAPE & REEL, Green	Industrial
ASM5I23S04AG-1-08-ST	5I23S04AG-1	8-pin 150-mil SOIC-TUBE, Green	Industrial
ASM5P23S04AG-1H-08-SR	5P23S04AG-1H	8-pin 150-mil SOIC-TAPE & REEL, Green	Commercial
ASM5P23S04AG-1H-08-ST	5I23S04AG-1H	8-pin 150-mil SOIC-TUBE, Green	Commercial
ASM5I23S04AG-1H-08-SR	5P23S04AG-1H	8-pin 150-mil SOIC-TAPE & REEL, Green	Industrial
ASM5I23S04AG-1H-08-ST	5I23S04AG-1H	8-pin 150-mil SOIC-TUBE, Green	Industrial
ASM5P23S04AG-2-08-SR	5P23S04AG-2	8-pin 150-mil SOIC-TAPE & REEL, Green	Commercial
ASM5P23S04AG-2-08-ST	5I23S04AG-2	8-pin 150-mil SOIC-TUBE, Green	Commercial
ASM5I23S04AG-2-08-SR	5P23S04AG-2	8-pin 150-mil SOIC-TAPE & REEL, Green	Industrial
ASM5I23S04AG-2-08-ST	5I23S04AG-2	8-pin 150-mil SOIC-TUBE, Green	Industrial
ASM5P23S04AG-2H-08-SR	5P23S04AG-2H	8-pin 150-mil SOIC-TAPE & REEL, Green	Commercial
ASM5P23S04AG-2H-08-ST	5I23S04AG-2H	8-pin 150-mil SOIC-TUBE, Green	Commercial
ASM5I23S04AG-2H-08-SR	5P23S04AG2H	8-pin 150-mil SOIC-TAPE & REEL, Green	Industrial
ASM5I23S04AG-2H-08-ST	5I23S04AGH	8-pin 150-mil SOIC-TUBE, Green	Industrial

Device Ordering Information





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Note: This product utilizes US# 6,646,463 Impedance Emulator Patent issued to PulseCore Semiconductor, dated 11-11-2003

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